


<div>Search Notes</div> <div></div>	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/678,445	KLUTH ET AL.	
	Examiner	Art Unit	
	Thien F. Tran	2811	

SEARCHED			
Class	Subclass	Date	Examiner
438	261, 287	1/26/2005	TT
438	488, 591	1/26/2005	TT

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
438	261, 287	1/26/2005	TT
438	488, 591	1/26/2005	TT

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR